S	Sear	earch Notes			

Application No.	Applicant(s)	
09/781,326	FURUSAWA ET AL.	
Examiner	Art Unit	
Robert B. Harrell	2142	

SEARCHED			
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
WEST for U.S. Patents and U.S. Pre- Publications		11/13/2006	RBH

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
All databases Full-Text and Abstract of: US Pre-Grant Pubs and Patents, US OCR, EPO, JPO, Derwent, IBM TDBs WEST	11/13/2006	RBH
Included, in addition to the following search terms, inventor and assignee names of this application	11/13/2006	RBH
WEST complete enclosed search history printout in box below	11/13/2006	RBH
L1 := ((master or parent) near2 (slave or child)) and ((client or user) near1 (location or proxim\$))and closest\$ 276 L1	11/13/2006	RBH
L2 := L1 and (current near3 (location or proxim\$)) 128 L2	- 11/13/2006	RBH
L3 := L2 and ((GPS or GPD) or ((global adj1 positioning) adj1 (system or device)) 81 L3	11/13/2006	RBH